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Search Notes						

Application/Control No.	Applicant(s)/Patent und Reexamination	ler
10/761,980	TUNG ET AL.	
Examiner	Art Unit	
Thinh T. Nguyen	2818	

SEARCHED					
Class	Subclass	Date	Examiner		
257	040	8/18/2006	TTN		
445	24	8/18/2006	TTN		
		-			

INT	INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner				
EAS	r pub	12/06/06	VIIV				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST	8/18/2006	TTN			
EAST	12/01/07	NET			